


<b>Search Notes</b> 	<b>Application/Control No.</b> 10585790	<b>Applicant(s)/Patent Under Reexamination</b> CHI ET AL.
	<b>Examiner</b> Brian-Yong S Kwon	<b>Art Unit</b> 1614

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Updated-STN, EAST, NPL	08/20/09	bk
Updated-continuity data, inventor name search		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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